



Docket No.: 2134-022

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Michael WOLLITZER

U.S. Patent Application No. 10/088,591

Filed: July 29, 2002

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: Confirmation No. 6844
:
: Group Art Unit: 2829
:
: Examiner: NGUYEN, TUNG X.

For: MEASURING PROBE FOR MEASURING HIGH FREQUENCIES AND METHOD OF
PRODUCING THE SAME

AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In response to the Office action of July 16, 2003, a Petition and fee for extending the response date two months from October 16, 2003 to December 16, 2003 being submitted herewith, please amend the above-identified application as follows:

RECEIVED
DEC 24, 2003
TECHNOLOGY CENTER 2800

Amendments to the Title:

Please amend the title to read:

MEASURING PROBE FOR MEASURING HIGH FREQUENCIES